EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	242	(714/24).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2007/03/27 19:53
L4	107	bios same (power voltage) same (sav$3 stor$3 record$3 writ$3) near2 (state volitile parameters status image) and (DMA DMAC "direct memory access" "memory controller" "io controller" "io processor") same (sav$3 stor$3 record$3 writ$3)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:05
L5	47	714/21.ccls. and power	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:28
L6	322	(714/22).CCLS.	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:35
L8	217	(714/15).CCLS. and power and (mark$3 valid validat$3 invalid invalidat$3)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:57
L9	5	((basic adj input adj output adj system BIOS) and (reset$3 restart$3 reboot$3) and (state image) and (valid invalid) and (resum$3 restart$3 wake waked waking reboot$3)).clm.	US-PGPUB	OR	ON	2007/03/27 21:25
L10	234	713/300,340.ccls. and (save saved saving record$3) near3 (state image)	US-PGPUB	OR	ON	2007/03/27 21:41
L12	168	713/300.ccls. and (save saved saving record$3) near3 (state image) and (BIOS basic adj input?output adj system)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 21:46
L13	89	suspend adj2 memory and power and (reset restore resume)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 22:22

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Edit an existing query or compose a new query in the Search Query Display.

Select a search number (#) to:

- Add a query to the Search Query Display
- Combine search queries using AND, OR, or NOT
- Delete a search
- Run a search

Tue, 27 Mar 2007, 10:27:57 PM EST

Search Query Display

Recent Search Queries

#1   ((power and (state or image) and (restore or reboot or resume or reset) and (bios or ~~basic input output system~~)) <in>metadata)

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